

# EM6K7T2R-VB Datasheet

# Dual N-Channel 20 V (D-S) MOSFET

PRODUCT SUMMARY					
V <sub>DS</sub> (V)	$R_{DS(on)max}\left(\Omega\right)$	I <sub>D</sub> (A)	Q <sub>g</sub> (Typ.)		
20	0.300 at V <sub>GS</sub> = 4.5 V	0.6			
	0.350 at V <sub>GS</sub> = 2.5 V	0.4	0.75		
	0.420 at V <sub>GS</sub> = 1.8 V	0.2	0.75		
	0.500 at V <sub>GS</sub> = 1.5 V	0.05			

#### **FEATURES**

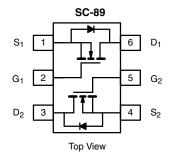
- TrenchFET® Power MOSFET
- 100 % R<sub>g</sub> Tested



ROHS

#### **APPLICATIONS**

- Load/Power Switching for Portable Devices
- Drivers: Relays, Solenoids, Lamps, Hammers, Displays, Memories
- Battery Operated Systems
- Power Supply Converter Circuits



ABSOLUTE MAXIMUM RATINGS (T <sub>A</sub> = 25 °C, unless otherwise noted)					
Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		$V_{DS}$	20	V	
Gate-Source Voltage		$V_{GS}$	± 12	7 v	
Continuous Drain Current /T = 150 °C\a	T <sub>A</sub> = 25 °C	ls.	0.60 <sup>a, b</sup>		
Continuous Drain Current (T <sub>J</sub> = 150 °C) <sup>a</sup>	T <sub>A</sub> = 70 °C	I <sub>D</sub>	0.49 <sup>a, b</sup>	Α	
Pulsed Drain Current		I <sub>DM</sub>	2	1	
Continuous Source-Drain Diode Current	T <sub>A</sub> = 25 °C	I <sub>S</sub>	0.18 <sup>a, b</sup>	Α	
Marrian Davis Disaination	T <sub>A</sub> = 25 °C	P <sub>D</sub>	0.22 <sup>a, b</sup>	— W	
Maximum Power Dissipation <sup>a</sup>	T <sub>A</sub> = 70 °C	' Б	0.14 <sup>a, b</sup>		
Operating Junction and Storage Temperature Range	je	T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	°C	

THERMAL RESISTANCE RATINGS					
Parameter		Symbol	Тур.	Max.	Unit
Maximum Junction-to-Ambient <sup>b</sup>	t ≤ 5 s	R <sub>thJA</sub>	470	565	°C/W
waximum junction-to-Ambient	Steady State	' 'thJA	560	675	O/ <b>VV</b>

#### Notes:

- a. Surface mounted on 1" x 1" FR4 board.
- b. t = 5 s.



Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static					I.		
Drain-Source Breakdown Voltage	$V_{DS}$	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	20			V	
V <sub>DS</sub> Temperature Coefficient ΔV <sub>DS</sub> /		I <sub>D</sub> = 250 μA		17		mV/°C	
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I <sub>D</sub> = 250 μA		- 1.8		1 IIIV/ C	
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	0.4		1	V	
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 8 \text{ V}$ $V_{DS} = 0 \text{ V}, V_{GS} = \pm 4.5 \text{ V}$			± 30 ± 1		
Zoro Coto Voltago Drain Current	1	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 4.5 \text{ V}$ $V_{DS} = 20 \text{ V}, V_{GS} = 0 \text{ V}$			1	μΑ	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{DS} = 20 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 85 ^{\circ}\text{C}$			3		
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} = \ge 5 \text{ V}, V_{GS} = 4.5 \text{ V}$	2			Α	
		$V_{GS} = 4.5 \text{ V}, I_D = 0.5 \text{ A}$		0.300			
Drain-Source On-State Resistance <sup>a</sup>	<b>P</b>	$V_{GS} = 2.5 \text{ V}, I_D = 0.2 \text{ A}$		0.350		$\Omega$	
Diam-Source On-State Resistance	R <sub>DS(on)</sub>	$V_{GS} = 1.8 \text{ V}, I_D = 0.2 \text{ A}$		0.420		32	
		$V_{GS} = 1.5 \text{ V}, I_D = 0.05 \text{ A}$		0.500		1	
Forward Transconductance	9 <sub>fs</sub>	$V_{DS} = 10 \text{ V}, I_{D} = 0.5 \text{ A}$		7.5		S	
Dynamic <sup>b</sup>						•	
Input Capacitance	C <sub>iss</sub>			43		pF	
Output Capacitance	C <sub>oss</sub>	$V_{DS} = 10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		14			
Reverse Transfer Capacitance	C <sub>rss</sub>			8			
Total Gate Charge	Q <sub>g</sub> .	$V_{DS} = 10 \text{ V}, V_{GS} = 8 \text{ V}, I_{D} = 0.6 \text{ A}$		1.3	2	nC	
<u> </u>				0.75	1.2		
Gate-Source Charge		$V_{DS} = 10 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 0.6 \text{ A}$		0.15			
Gate-Drain Charge	$Q_gd$			0.13			
Gate Resistance	$R_g$	f = 1 MHz	2.4	12.2	24.4	Ω	
Turn-On Delay Time	t <sub>d(on)</sub>			11	20		
Rise Time	t <sub>r</sub>	$V_{DD} = 10 \text{ V}, R_L = 20 \Omega$ $I_D \cong 0.5 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_q = 1 \Omega$		16	24	ns	
Turn-Off Delay Time	rn-Off Delay Time t <sub>d(off)</sub>			26	39		
Fall Time	t <sub>f</sub>			11	20		
<b>Drain-Source Body Diode Characterist</b>	ics						
Pulse Diode Forward Current <sup>a</sup>	I <sub>SM</sub>				2	Α	
Body Diode Voltage	$V_{SD}$	I <sub>S</sub> = 0.5 A		8.0	1.2	V	
Body Diode Reverse Recovery Time				10	15	ns	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	$Q_{rr}$ $I_F = 0.5 \text{ A, dI/dt} = 100 \text{ A/}\mu\text{s}$		2	4	nC	
Reverse Recovery Fall Time	t <sub>a</sub>	i <sub>F</sub> = 0.5 A, αί/αι = 100 Α/μ5		5		ns	
Reverse Recovery Rise Time	t <sub>b</sub>			5			

2

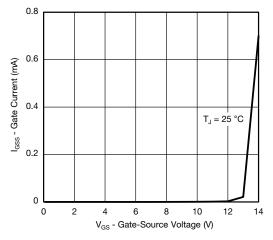
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

a. Pulse test; pulse width  $\leq$  300  $\mu s,$  duty cycle  $\leq$  2 %. b. Guaranteed by design, not subject to production testing.

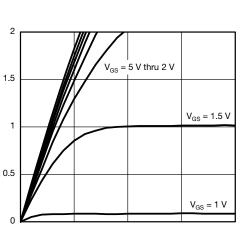
I<sub>D</sub> - Drain Current (A)



### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

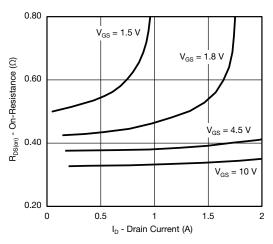


Gate Current vs. Gate-Source Voltage

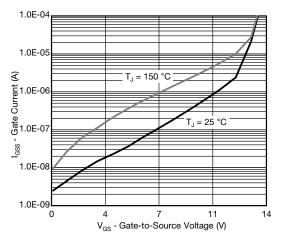


**Output Characteristics** 

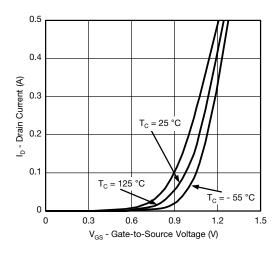
V<sub>DS</sub> - Drain-to-Source Voltage (V)



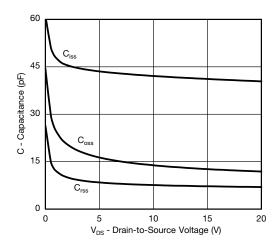
On-Resistance vs. Drain Current



Gate Current vs. Gate-Source Voltage



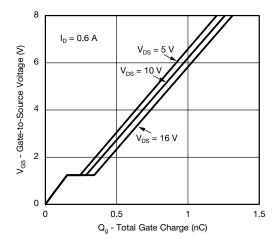
**Transfer Characteristics** 



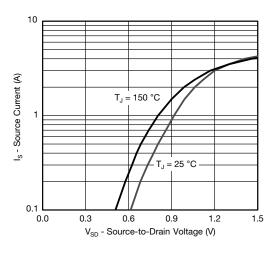
Capacitance



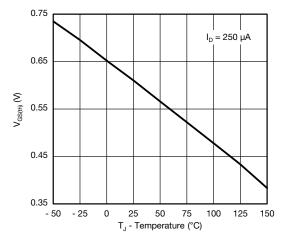
### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



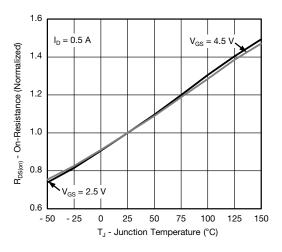
#### **Gate Charge**



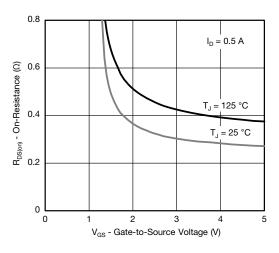
Soure-Drain Diode Forward Voltage



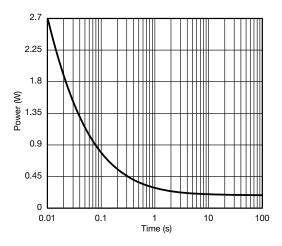
**Threshold Voltage** 



On-Resistance vs. Junction Temperature



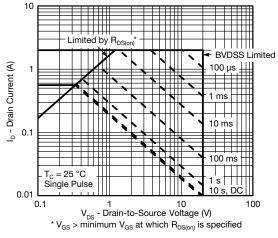
On-Resistance vs. Gate-to-Source Voltage



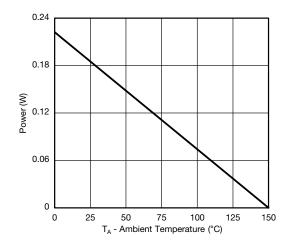
Single Pulse Power, Junction-to-Ambient



#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

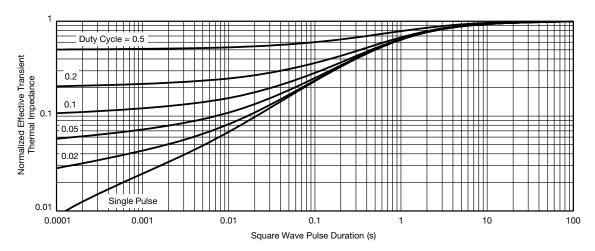






Power Derating, Junction-to-Ambient

<sup>\*</sup> The power dissipation  $P_D$  is based on  $T_{J(max)} = 150$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

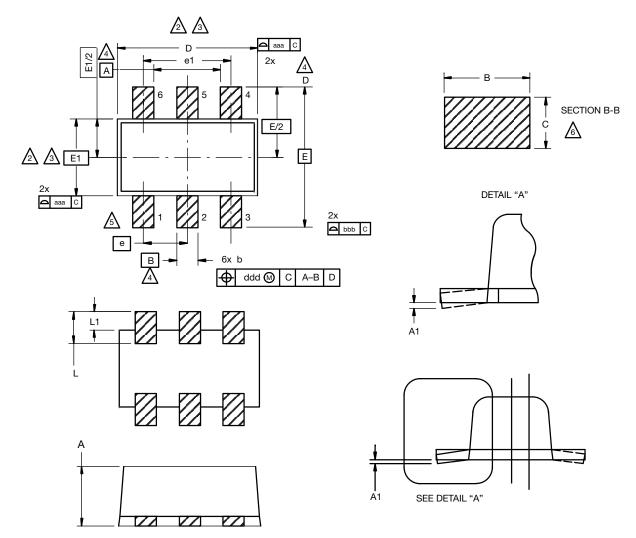


Normalized Thermal Transient Impedance, Junction-to-Ambient

服务热线:400-655-8788 5



# **SC-89 6-Leads (SOT-563F)**



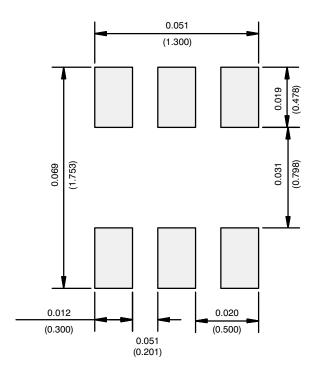
#### Notes

- 1. Dimensions in millimeters.
- Dimension D does not include mold flash, protrusions or gate burrs. Mold flush, protrusions or gate burrs shall not exceed 0.15 mm per dimension E1 does not include interlead flash or protrusion, interlead flash or protrusion shall not exceed 0.15 mm per side.
- 3. Dimensions D and E1 are determined at the outmost extremes of the plastic body exclusive of mold flash, the bar burrs, gate burrs and interlead flash, but including any mismatch between the top and the bottom of the plastic body.
- 4. Datums A, B and D to be determined 0.10 mm from the lead tip.
- 5. Terminal numbers are shown for reference only.
- 6. These dimensions apply to the flat section of the lead between 0.08 mm and 0.15 mm from the lead tip.

DIM.	MILLIMETERS				
Dilvi.	MIN.	NOM.	MAX.		
Α	0.56	0.58	0.60		
A1	0	0.02	0.10		
b	0.15	0.22	0.30		
С	0.10	0.14	0.18		
D	1.50	1.60	1.70		
E	1.50	1.60	1.70		
E1	1.15	1.20	1.25		
е	0.45	0.50	0.55		
e1	0.95	1.00	1.05		
L	0.25	0.35	0.50		
L1	0.10	0.20	0.30		



### **RECOMMENDED MINIMUM PADS FOR SC-89: 6-Lead**



Recommended Minimum Pads Dimensions in Inches/(mm)



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DMN2080UCB4-7 DMN61D9UWQ-13 US6M2GTR DMN31D5UDJ-7 DMP22D4UFO-7B DMN1006UCA6-7 DMN16M9UCA6-7
STF5N65M6 IRF40H233XTMA1 STU5N65M6 DMN6022SSD-13 DMN13M9UCA6-7 DMTH10H4M6SPS-13 DMN2990UFB-7B
IPB80P04P405ATMA2 2N7002W-G MCAC30N06Y-TP MCQ7328-TP NTMC083NP10M5L BXP7N65D BXP4N65F AOL1454G
WMJ80N60C4 BXP2N20L BXP2N65D BXT1150N10J BXT1700P06M TSM60NB380CP ROG RQ7L055BGTCR DMNH15H110SK3-13
SLF10N65ABV2 BSO203SP BSO211P IPA60R230P6